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One of the problems of X-ray optics is the absence of tools to change the divergence of X-rays. Although several X-ray optical instruments have been developed during the last decades, using total reflection etc., there is no instrument available which can be compared to light optical lenses. The Delta-Crystal, with its diverging lattice parameters, is able to collect a diverging X-ray beam to a parallel one and vice versa

The most simple application of the linear (onedimensional) Delta-Crystal is its use as a collecting and amplifying monochromator. The diverging beam of a point-like X-ray source can be collected to a parallel beam where the intensity of the X-rays could be increased by a factor up to 100, if the change of the lattice parameters is in the range of 1%/cm. A proper adaptation to the beam geometry requires an additional bending and cutting of the Delta-Crystal.

Two- and three-dimensional Delta-Crystals can be used like optical lenses to construct X-ray microscopes and telescopes.

In literature the growing of Delta-Crystals is mentioned as a growing fault, and high efforts have been made to prevent the changing of the lattice parameter during the growing process. Nevertheless the aimed growing of even linear (onedimensional) Delta-Crystals leads to large problems. Serious efforts have to be made to improve the growing procedures, which exceeds our own crystal growing potential.

One of the aims of this paper is to convince crystal growers that the challenge of growing Delta-Crystals will lead to a high reward.

PS-14.01.09

A NOVEL EXPERIMENTAL SYSTEM FOR HIGH RESOLUTION ANALYSIS OF ELECTRON DISTRIBUTION IN RESOLUTION ANALYSIS OF ELECTRON DISTRIBUTION IN CRYSTALS. By F.P.Okamura and K.Yukino, National Institute for Research in Inorganic Materials, Namiki 1-1, Tsukuba, Ibaraki 305, and K.Yamamoto, Institute of Applied Physics, University of Tsukuba, Tsukuba, Ibaraki 305, K.Hoshikawa, Institute for Material Research, Tohoku University, Katahira, Sendai 980, and T.Hori, S.Yoshimachi, R. Yokoyama, H. Kawasaki, K. Tsukamoto, and H. Izawa Rigaku Co., 3-9-12 Matsubara-cho, Akishima, Tokyo 196, Japan.

We recently developed an X-ray single crystal diffraction system equipped with an open tube ty -pe X-ray generator which can be operated at a maximum voltage of 200kV(Okamura et al., Collect-ed Abstracts of AsCA'92 Inagural Conference, 16C Basic specifications for the system are as follows:

Generator

tube voltage: 20-200kV, tube current: 2-15mA

power:

target:

Cu, Mo, Ag, W off-centered four circle (Huber 512) Goniometer: Collimator: 0.2, 0.5, 1.0, 2.0, 3.0 mm

2kW

The especially high tube voltage up to 200kV enables us the use of WKa radiation (λ =0.2123A) with high efficiency. In the present study on C(diamond), Si and Ge, we newly introduced the combined use of a monochromator and SSD(pure Ge), for data collection by WKa radiation(0.226). for data collection by WK α radiation(0 < 2 δ < 110°). The results of the electron density analy ses based on the above three data sets clearly indicate that high resolution analysis is attain -ed by use of this extremely short wavelength.

PS-14.01.10 FIRST TESTING AND APPLICATIONS OF BRAGG-FRESNEL CRYSTAL OPTICS AT THE ESRF MICROFOCUS BEAMLINE

Ya.Hartman, I.Snigireva, A.Snigirev*.

Institute of Microelectronics Technology Russian Academy of Sciences, Chernogolovka Moscow Region, Russia,

P.Engstrom, C.Riekel

European Synchrotron Radiation Facility, Grenoble, France.

Bragg-Fresnel optics based on single nearly perfect crystal (mainly silicon) has been proposed as high efficient X-ray optics with a resolution better than 1µm (V.V.Aristov, A.A.Snigirev, Yu.A.Basov, A.Yu.Nikulin, AIP Conf.Proc.,1986, 147, 253). The efficiency close to 40% has been demonstrated for linear and circular phase Bragg-Fresnel lenses (BFL) (Aristov, Yu.A.Basov, T.E.Gourcev, A.A.Snigirev, T.Ishkawa, K.Izumi, S.Kikuta, Jpn. J. Appl. Phys., 1992, 31, 2616; Yu. A. Basov, T.L. Pravdivtseva, A. A. Snigirev, M. Belakhovsky, P. Dhez, A. Freund, NIM, 1991, A308, 363). The spatial resolution was, however limited by the geometrically demagnified image of the effective x-ray source. The new generation of storage rings like ESRF provides in addition to the unprecedented beam power excellent parameters for optical setups such as:
-large distance source-to-optical element ~30-40m

-small electron beam size in the storage ring ~100 µm That means, that for a reasonable focal distance of 0.1m-0.4m, demagnification of more than factor 100 becomes possible and resolution is defined by the diffraction limit of the optics.

The performance of the BFL was studied at the Microfocus beamline-1 of the European Synchrotron Radiation Facility either in white and monochromatic beam modes. undulator with source size X*Z=132*89µm² was used.

The potential for tuning with BF-optics was demonstrated by focusing of a linear silicon-based BFL for 111-reflection in a white beam mode in the energy range 8 < E < 60keV. A focus spot size of $1\mu m$ was observed by high resolution film and was confirmed by fluorescence knife technique. The focusing efficiency about 35% was measured

use of the linear BFL-based microprobe for microdiffraction by small samples such as thin wires and organic fibers was demonstrated. Alignment and scanning of the specimens of about 10 µm is possible and can be improved. Kirkpatrick-Baez BFL-based microprobe is under A.Snigirev, Rev. Sci. development (U.Bonse, C.Rickel, A.Snigirev, Rev. Sci. Instrum., 1992, 63, 622; V.V.Aristov, Yu.A.Basov, Ya.M.Hartman, C.Rickel, A.A.Snigirev, Proc. of IXCOM-XIII Conf.,1992, to be published.).

Imaging properties of a circular BFL was investigated in backscattering geometry for energies of about 6keV (Si-333 reflection). It was demonstrated that BFL is acting. - like a - as an imaging device and as usual lens a Fouriertransformer for the diffraction by a narrow slit. The circular BFL was applied to study the size and the shape of the undulator source.

the Bragg-Fresnel crystal-based optics In summary, highly promising demonstrated unprecedented and